# **General Purpose Transistors**

### **PNP Silicon**

#### **Features**

 These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

#### **MAXIMUM RATINGS**

Rating	Symbol	Value	Unit
Collector - Emitter Voltage	V <sub>CEO</sub>	-60	Vdc
Collector - Base Voltage	V <sub>CBO</sub>	-60	Vdc
Emitter - Base Voltage	V <sub>EBO</sub>	-5.0	Vdc
Collector Current - Continuous	I <sub>C</sub>	-600	mAdc
Collector Current - Peak (Note 3)	I <sub>CM</sub>	-1200	mAdc

#### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Total Device Dissipation FR-5 Board (Note 1) @T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	225 1.8	mW mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	556	°C/W
Total Device Dissipation Alumina Substrate, (Note 2) @T <sub>A</sub> = 25°C Derate above 25°C	P <sub>D</sub>	300 2.4	mW mW/°C
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	417	°C/W
Junction and Storage Temperature	T <sub>J</sub> , T <sub>stg</sub>	-55 to +150	°C

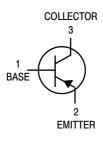
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

- 1. FR-5 =  $1.0 \times 0.75 \times 0.062$  in.
- 2. Alumina = 0.4  $\times$  0.3  $\times$  0.024 in. 99.5% alumina.
- 3. Reference SOA curve.



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SOT-23 (TO-236AB) CASE 318 STYLE 6

#### **MARKING DIAGRAM**



2F = Device Code M = Date Code\* • = Pb-Free Package

(Note: Microdot may be in either location)
\*Date Code orientation and/or overbar may
vary depending upon manufacturing location.

#### **ORDERING INFORMATION**

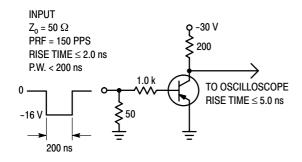
Device	Package	Shipping <sup>†</sup>
MMBT2907ALT1G	SOT-23 (Pb-Free)	3000 Tape & Reel
MMBT2907ALT3G	SOT-23 (Pb-Free)	10,000 Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## $\textbf{ELECTRICAL CHARACTERISTICS} \ (T_A = 25^{\circ}\text{C unless otherwise noted})$

Charact	Symbol	Min	Max	Unit	
OFF CHARACTERISTICS					
Collector-Emitter Breakdown Voltage (Not $(I_C = -1.0 \text{ mAdc}, I_B = 0)$ $(I_C = -10 \text{ mAdc}, I_B = 0)$	V <sub>(BR)CEO</sub>	-60 -60	- -	Vdc	
Collector - Base Breakdown Voltage (I <sub>C</sub> =	-10 μAdc, I <sub>E</sub> = 0)	V <sub>(BR)CBO</sub>	-60	_	Vdc
Emitter – Base Breakdown Voltage (I <sub>E</sub> = -	Emitter – Base Breakdown Voltage (I <sub>E</sub> = –10 μAdc, I <sub>C</sub> = 0)			_	Vdc
Collector Cutoff Current (V <sub>CE</sub> = −30 Vdc,	V <sub>EB(off)</sub> = -0.5 Vdc)	I <sub>CEX</sub>	-	-50	nAdc
Collector Cutoff Current $(V_{CB} = -50 \text{ Vdc}, I_E = 0)$ $(V_{CB} = -50 \text{ Vdc}, I_E = 0, T_A = 125^{\circ}\text{C})$	I <sub>CBO</sub>	- -	-0.010 -10	μAdc	
Base Cutoff Current ( $V_{CE} = -30 \text{ Vdc}$ , $V_{EE}$	<sub>8(off)</sub> = -0.5 Vdc)	I <sub>BL</sub>	-	-50	nAdc
ON CHARACTERISTICS					
DC Current Gain $ \begin{array}{l} (I_C = -0.1 \text{ mAdc, V}_{CE} = -10 \text{ Vdc)} \\ (I_C = -1.0 \text{ mAdc, V}_{CE} = -10 \text{ Vdc)} \\ (I_C = -1.0 \text{ mAdc, V}_{CE} = -10 \text{ Vdc)} \\ (I_C = -150 \text{ mAdc, V}_{CE} = -10 \text{ Vdc)} \\ (I_C = -500 \text{ mAdc, V}_{CE} = -10 \text{ Vdc)} \end{array} $	e 4)	h <sub>FE</sub>	75 100 100 100 50	- - - 300	_
Collector – Emitter Saturation Voltage (No $(I_C = -150 \text{ mAdc}, I_B = -15 \text{ mAdc})$ (Note $(I_C = -500 \text{ mAdc}, I_B = -50 \text{ mAdc})$	V <sub>CE(sat)</sub>	- -	-0.4 -1.6	Vdc	
Base – Emitter Saturation Voltage (Note 4 $(I_C = -150 \text{ mAdc}, I_B = -15 \text{ mAdc})$ ( $I_C = -500 \text{ mAdc}, I_B = -50 \text{ mAdc})$	V <sub>BE(sat)</sub>	- -	-1.3 -2.6	Vdc	
SMALL-SIGNAL CHARACTERISTICS				•	•
Current – Gain – Bandwidth Product (Note (I <sub>C</sub> = –50 mAdc, V <sub>CE</sub> = –20 Vdc, f = 10	f <sub>T</sub>	200	-	MHz	
Output Capacitance (V <sub>CB</sub> = -10 Vdc, I <sub>E</sub> =	0, f = 1.0 MHz)	C <sub>obo</sub>	-	8.0	pF
Input Capacitance (V <sub>EB</sub> = -2.0 Vdc, I <sub>C</sub> =	C <sub>ibo</sub>	-	30		
SWITCHING CHARACTERISTICS					
Turn-On Time		t <sub>on</sub>	-	45	
Delay Time	$(V_{CC} = -30 \text{ Vdc}, I_C = -150 \text{ mAdc}, I_{B1} = -15 \text{ mAdc})$	t <sub>d</sub>	-	10	
Rise Time	.51 .3(30)	t <sub>r</sub>	-	40	
Turn-Off Time		t <sub>off</sub>	-	100	ns
Storage Time	$(V_{CC} = -6.0 \text{ Vdc}, I_{C} = -150 \text{ mAdc}, I_{B1} = I_{B2} = -15 \text{ mAdc})$	t <sub>s</sub>	-	80	1
Fall Time	181 – 182 – 10 117 dd)	t <sub>f</sub>	-	30	1

- 4. Pulse Test: Pulse Width  $\leq$  300  $\mu$ s, Duty Cycle  $\leq$  2.0%.
- 5.  $f_T$  is defined as the frequency at which  $|h_{fe}|$  extrapolates to unity.





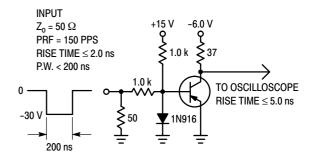


Figure 2. Storage and Fall Time Test Circuit

#### **TYPICAL CHARACTERISTICS**

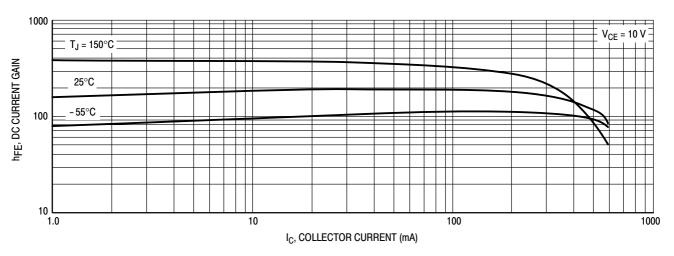


Figure 3. DC Current Gain

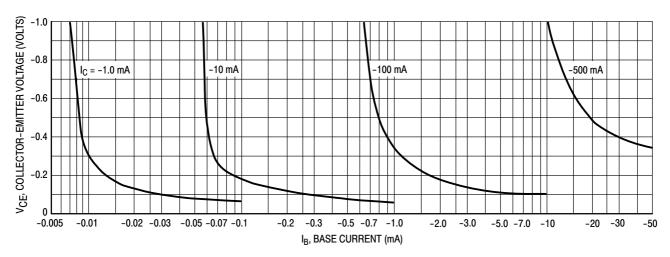


Figure 4. Collector Saturation Region

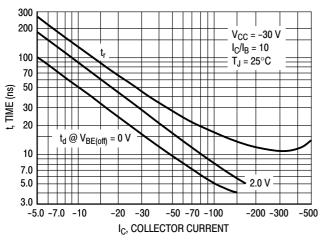


Figure 5. Turn-On Time

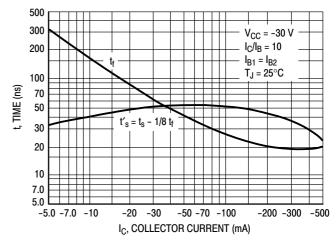
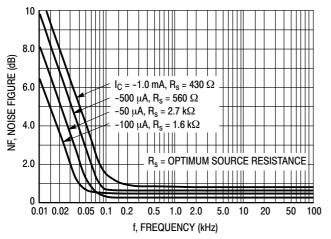


Figure 6. Turn-Off Time

# TYPICAL SMALL-SIGNAL Characteristics NOISE FIGURE

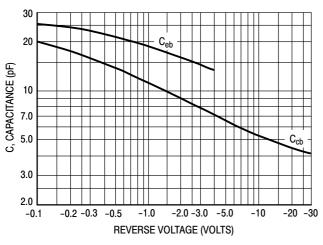
 $V_{CE}$  = 10 Vdc,  $T_A$  = 25°C



8.0 NF, NOISE FIGURE (dB) 6.0  $I_C$  = -50  $\mu A$ -100 μA -500 μA 4.0 1.0 mA 2.0 200 50 100 1.0 k 2.0 k 5.0 k 10 k 20 k 50 k Rs, SOURCE RESISTANCE (OHMS)

Figure 7. Frequency Effects

Figure 8. Source Resistance Effects



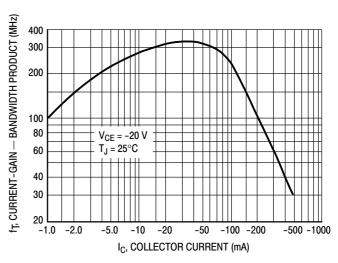
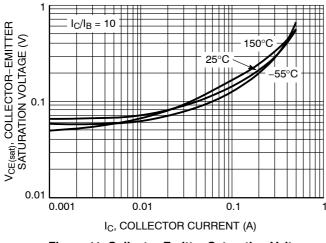


Figure 9. Capacitances

Figure 10. Current-Gain - Bandwidth Product



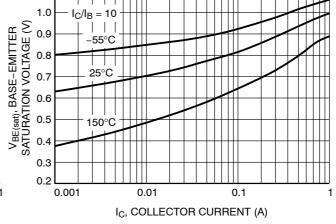


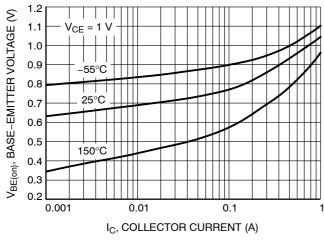
Figure 11. Collector Emitter Saturation Voltage vs. Collector Current

Figure 12. Base Emitter Saturation Voltage vs.
Collector Current

1.1

# TYPICAL SMALL-SIGNAL Characteristics NOISE FIGURE

 $V_{CE}$  = 10 Vdc,  $T_A$  = 25°C



+0.5 0  $R_{\theta VC}$  for  $V_{CE(sat)}$ COEFFICIENT (mV/°C) -0.5 -1.0 -1.5  $R_{\theta VB}$  for  $V_{BE}$ -2.0 -2.5 -0.2 -0.5 -1.0 -2.0 -5.0 -10 -20 -50 -100 -200 -500 -0.1 I<sub>C</sub>, COLLECTOR CURRENT (mA)

Figure 13. Base Emitter Voltage vs. Collector
Current

Figure 14. Temperature Coefficients

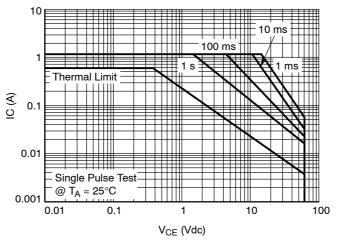
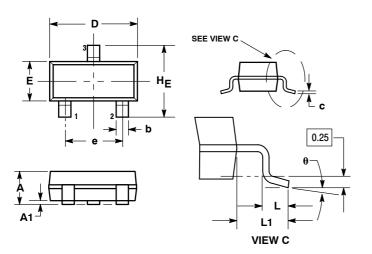


Figure 15. Safe Operating Area

#### PACKAGE DIMENSIONS

SOT-23 (TO-236) CASE 318-08 **ISSUE AP** 



#### NOTES:

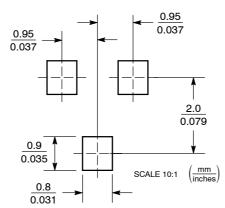
- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M. 1982
- 2. 3.
- CONTROLLING DIMENSION: INCH.
  MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL
- DIMENSIONS D AND E DO NOT INCLUDE MOLD FLASH,

PRO	RUSION LLIMETERS ORRS.		INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.89	1.00	1.11	0.035	0.040	0.044
A1	0.01	0.06	0.10	0.001	0.002	0.004
b	0.37	0.44	0.50	0.015	0.018	0.020
С	0.09	0.13	0.18	0.003	0.005	0.007
D	2.80	2.90	3.04	0.110	0.114	0.120
E	1.20	1.30	1.40	0.047	0.051	0.055
е	1.78	1.90	2.04	0.070	0.075	0.081
L	0.10	0.20	0.30	0.004	0.008	0.012
L1	0.35	0.54	0.69	0.014	0.021	0.029
HE	2.10	2.40	2.64	0.083	0.094	0.104
θ	0°		10°	0°		10°

STYLE 6 PIN 1. BASE 2 **EMITTER** 

# COLLECTOR

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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